## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10660683	EBISAWA, TAKASHI
Examiner	Art Unit
Patel, Jayesh A	2624

SEARCHED						
Class	Subclass	Date	Examiner			
382	273,275,274,271,266,264,263,256,258,266	01/22/07	JP			
358	462	06/17/07	JP			

SEARCH NOTES				
Search Notes	Date	Examiner		
See attached East Search History				

	INTERFERENCE SEARCH			
Class	Subclass	Date	Examine	

U.S. Patent and Trademark Office Part of Paper No. :